

**Search Notes**

Application/Control No.

10/775,629

Examiner

Hanh Nguyen

Applicant(s)/Patent under  
Reexamination

ZEIRA ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	318	6/20/2007	HN
	329		
	330		
	341		
	468		
	395.4		
	333		
	341		
	395.21		
370	332		
455	436		
	452.2		
	13.4		
	522		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/20/2007	HN